

Construction Analysis Report

Applicant	Customer: 深圳市先研科技有限公司
	Date Received: Oct-08-2022
	Device Part Number: 5962R1022102VSC
	Date Code: N/A
Product Spec.	Device Type: Synchronous Buck Converter
	Manufacturer: Texas Instruments
	Quantity Received: 29
	Issue No: Top22101742-Final
	Visual Inspection
	Solderability Test
	De-Cap Inspection
	Functional Tests
Item selection	X-Ray Inspection
	Programming Testing
	Electrical Silicon Test
	ROHS Test
Tested by	Juge F. Outhour
	Signature() Signature()
Poviow by	Joyce Fr. Anthong
Review by	Tatoick Dun
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Toptest International Technology Limited



Tel:(086) 0755-83152001 Skype:tpst-lab Email: info@tpst-lab.com Website: http://www.tpst-lab.com

Visual Inspection Test Result	Chart	Functional result chart		
Tested sample(s): PCS Acceptable Sample(s): PCS Rejected Sample(s): PCS		Tested sample(s): 29 PCS Acceptable Sample(s): 22 PCS Rejected Sample(s): 7 PCS		
		7, Functional pie chart 24.1% 22, 22, 75.9%		
Shipment Details				
Number of tubes received	2			
Condition of tubes	□Good ∎Fair	r □Poor □ Other		
Packing Material	□Anti-static Ba	ag		
Type of carrier	□trays ∎tube	es □reels □bags □other		
Condition of protection	□ESD protect	ion □MSL protection ∎Other		
Tubes open date/time	□Parts transp	ort process ∎After received □Other		
Tray Conditions (if applicable)	□Suitable tray	vs □Unsuitable trays ∎Not applicable		
Type of Parts Package	Manufacturer	logo		
20-Pin CFP		TEXAS INSTRUMENTS		

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Functional Test

Description

All 29 devices were tested for Input Voltage Range, Enable pin logic, PH pin

Switching signal, feedback regulation Voltage and Output Voltage Range tests at

room temperature.

Device Features

- peak efficiency: 96.6% (VO = 3.3 V)
- Integrated 58-mΩ /50-mΩ MOSFETs
- Power rail: 3 to 7 V on VIN
- 6-A Maximum output current
- Flexible switching frequency options:
 - 100-kHz to 1-MHz Adjustable internal oscillator

Device Pin Configuration

Testing Center La



Room 25C, CaiHong Building, Futian District Shenzhen, Guangdong, China



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Reference Tested Circuit

Device test data and details were shown as below:

Tested parameters:

- 1. Input Voltage Range $P_{VIN}\&V_{IN}$: 3V~7V
- 2. Enable pin ON/OFF logic
- 3. PH pin Switching signal
- 4. Output Voltage reference V_{REF} : 0.792V~0.816V
- 5. Output Voltage Range V_{OUT}: 1.584V~1.632V(R_{TOP}= R_{BOTTOM} =10k Ω)

Test data(Pass):

Device Quantity	Input Voltage Range P _{VIN} &V _{IN} : 3V~7V	Enable pin ON/OFF logic	PH pin Switching signal	Output Voltage reference V _{REF} : 0.792V~ 0.816V	Output Voltage Range V _{OUT} : 1.584V~1.632V	Results
22	Pass	Pass	Pass	Pass	Pass	Favorable

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Test data(Failed):

De ^v Qua	vice Intity	Input Voltage Range P _{VIN} &V _{IN} : 3V~7V	Enable pin ON/OFF logic	PH pin Switching signal	Output Voltage reference V _{REF} : 0.792V~ 0.816V	Output Voltage Range V _{OUT} : 1.584V~1.632V	Results
d/c: 106	1	Failed	Failed	Failed	34.17mV	63.72mV	Unfavorable
d/c: 105	1	Failed	Failed	Failed	24.09mV	54.06mV	Unfavorable
d/c: 306	1	Failed	Failed	Failed	34.20mV	63.72mV	Unfavorable
d/c: 332	1	Failed	Failed	Failed	24.16mV	54.05mV	Unfavorable
d/c: 102	1	Failed	Failed	Failed	34.00mV	63.89mV	Unfavorable
d/c: 343	1	Failed	Failed	Failed	43.85mV	74.09mV	Unfavorable
d/c: 333	1	Failed	Failed	Failed	24.21mV	43.73mV	Unfavorable

Note: The pictures of details were shown as below

Test traces:



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Appendix

Parts were received; the tubes(bags, reels, tubs, trays) and the device

inspection figures were shown as below:

Tubes as received	
Device top view	Device bottom view

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